

Search Notes

Application/Control No.

10/074,174

Examiner

Hanh Nguyen

Applicant(s)/Patent under
Reexamination

LU, HAW-MINN

Art Unit

2616

SEARCHED

Class	Subclass	Date	Examiner
370	388	6/20/2006	HN
	254		
	367		
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	400		
370	389		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
See Searches Notes		6/20/2006	HN

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	6/20/2006	HN